



WANSEMI
万芯半导体

WX012BP02N2

Enhancement Mode P-Channel Power MOSFET

DFN2X2/PMOS/-16V/ \pm 12V/-0.65V/-20A/15.5m Ω

Rev1.1



-16V, 15.5mΩ, -20A, P-Channel MOSFET

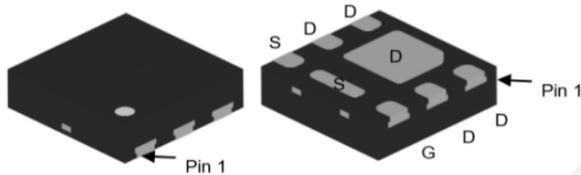
1.Features

- ◆ High Power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface Mount Package

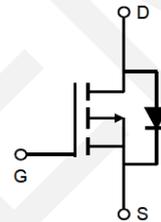
V _{DS} Typ.	R _{DS(on)} Typ.	I _D Max.
-16V	12.7mΩ @ -10V	-20A
	15.5mΩ @ -4.5V	
	20.9mΩ @ -2.5V	

2.Applications

- ◆ Battery Protection
- ◆ Battery Powered Systems
- ◆ Power Management in Notebook Computer
- ◆ Portable Equipment



Pin Description
DFN2X2-6L



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX012BP02N2	012P02	DFN2X2	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	-16	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current-Continuous	I _D	-20	A
Drain Current (Pulse)	I _{DM}	-80	A
Maximum Power Dissipation	P _D	1.9	W
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Maximum Junction-to-Ambien	$R_{\theta JA}$	64	$^{\circ}C/W$

Note 2: When mounted on 1 inch square copper board $t \leq 10$ sec The value in any given application depends on the user's specific board design.

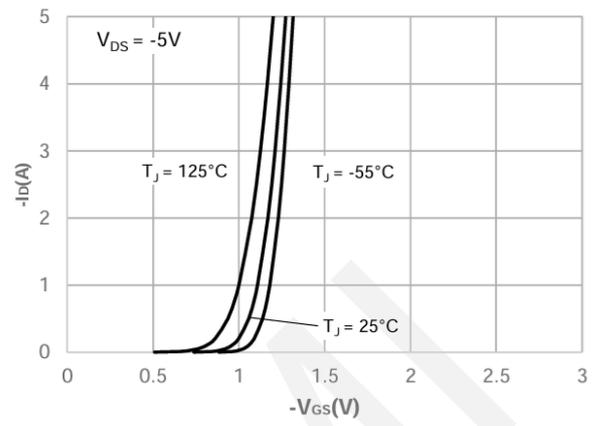
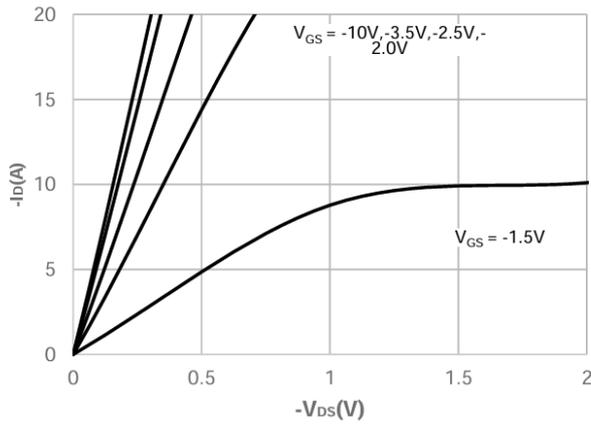
6. Electrical Characteristics at $T_a=25^{\circ}C$ (Note 3)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = -250\mu A, V_{GS} = 0V$	-16	-	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -16V, V_{GS} = 0V$	-	-	-1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=-250\mu A$	-0.4	-0.65	-1.0	V
Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = -6A, V_{GS} = -10V$	-	12.7	17	$m\Omega$
		$I_D = -4.1A, V_{GS} = -4.5V$	-	15.5	20	$m\Omega$
		$I_D = -3A, V_{GS} = -2.5V$	-	20.9	27	$m\Omega$
Input Capacitance	C_{iss}	$V_{GS}=0V,$ $V_{DS}=-8V,$ Frequency=1.0MHz	-	1014	-	pF
Output Capacitance	C_{oss}		-	167	-	pF
Reverse Transfer Capacitance	C_{rss}		-	135	-	pF
Turn-ON Delay Time	$t_{d(on)}$		-	7.2	-	ns
Turn-ON Rise Time	t_r	$V_{DD} = -10V, I_D = -3A,$ $R_G = 3\Omega, V_{GS} = -4.5V$	-	17.5	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	62	-	ns
Turn-ON Fall Time	t_f		-	45	-	ns
Total Gate Charge	Q_g	$V_{DS} = -8V,$ $V_{GS} = 0$ to $-4.5V,$ $I_D = -3A$	-	14	-	nC
Gate-Source Charge	Q_{gs}		-	2.2	-	nC
Gate-Drain Charge	Q_{gd}		-	2.9	-	nC
Diode Forward Voltage	V_{SD}	$I_{SD} = -4.1A, V_{GS} = 0$	-0.5	-	-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

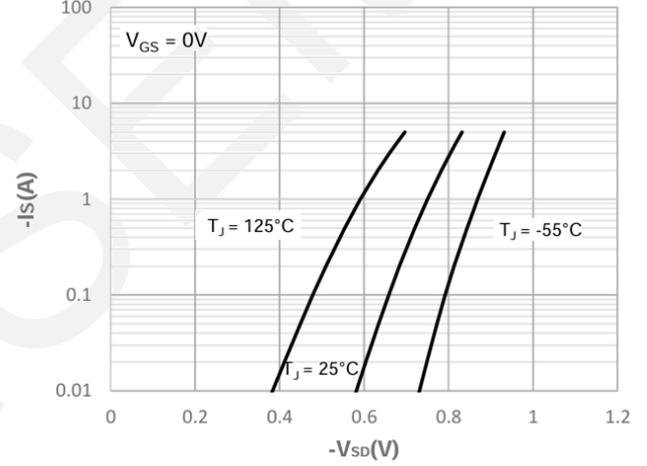
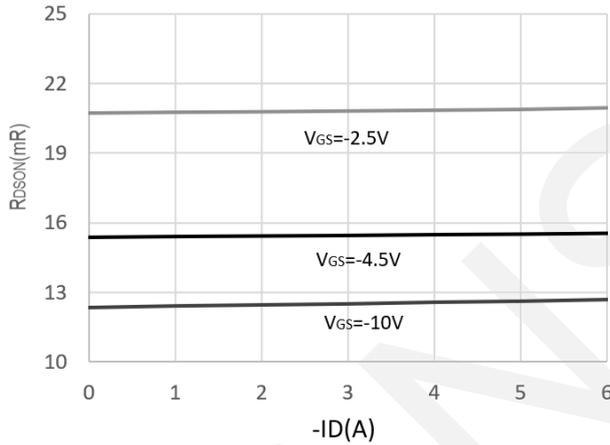


7. Typical electrical and thermal characteristics



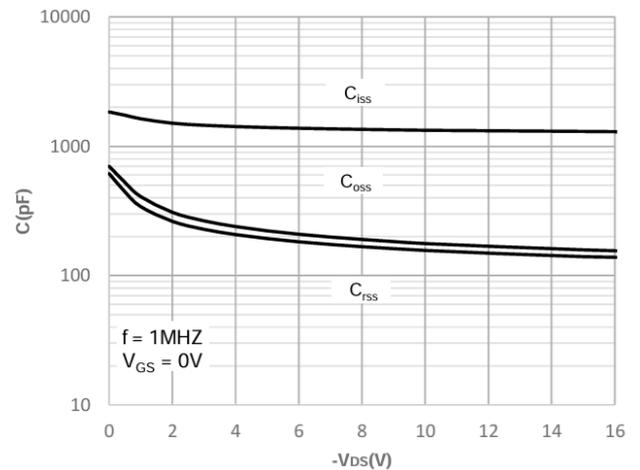
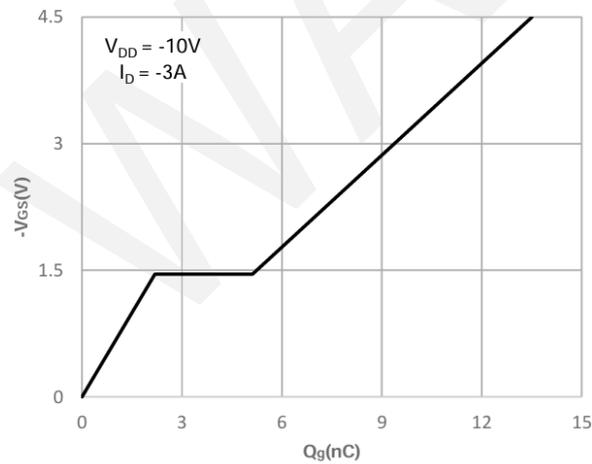
Typical Output Characteristics

Typical Transfer Characteristics



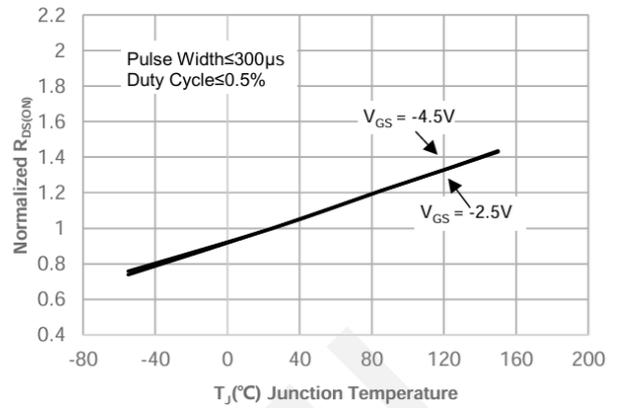
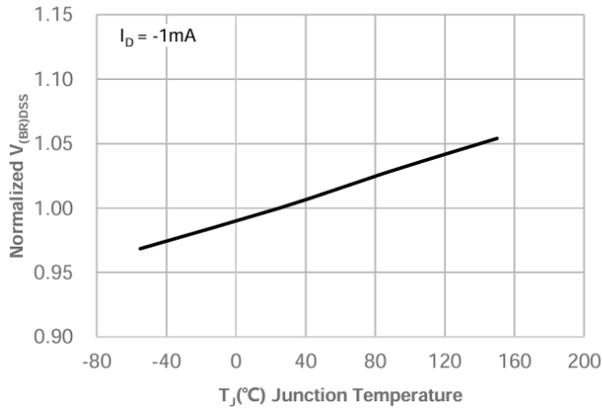
On-resistance vs. Drain Current

Body Diode Characteristics

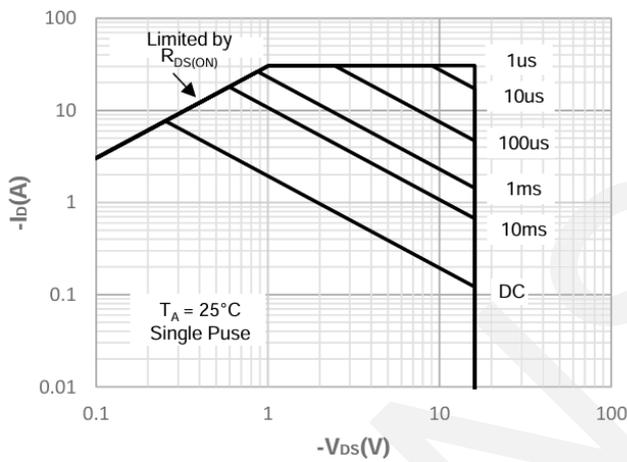


Gate Charge Characteristics

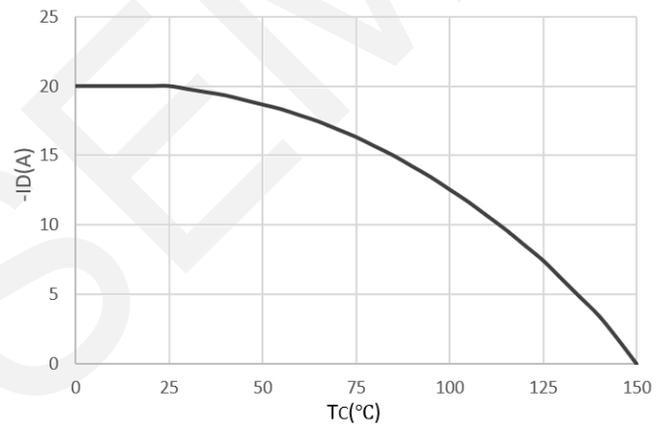
Capacitance Characteristics



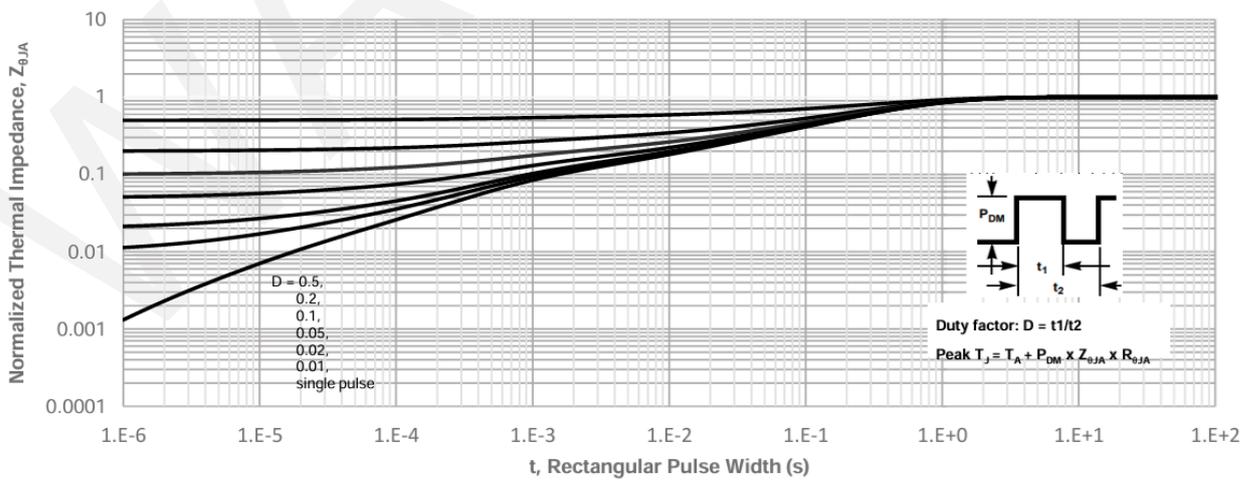
Normalized Breakdown voltage vs. Junction Temperature



Normalized on Resistance vs. Junction Temperature



Normalized Breakdown voltage vs. Junction Temperature

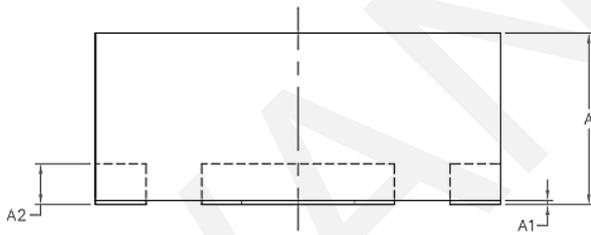
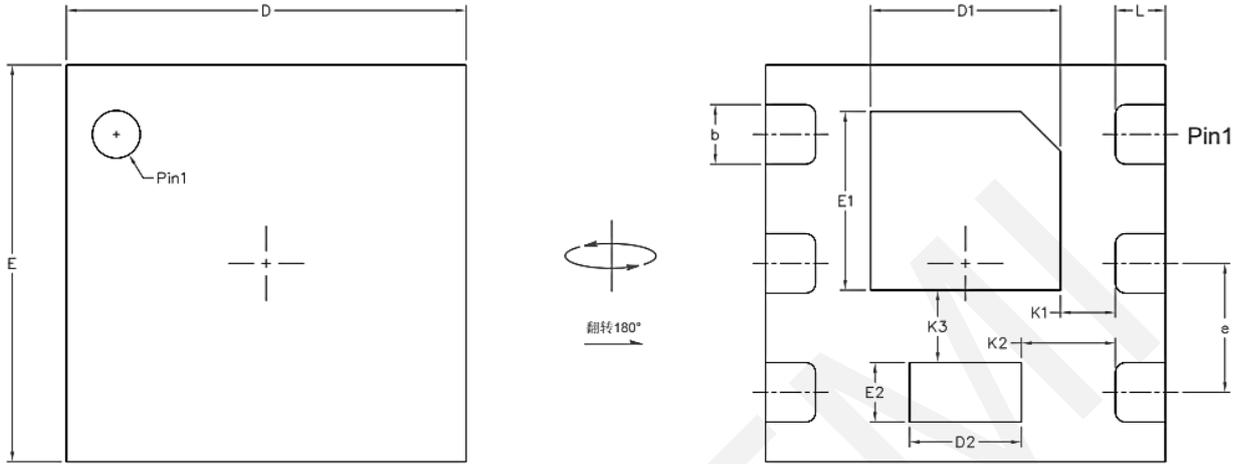


Current De-rating

Normalized Maximum Transient Thermal Impedance



8.Package Dimensions



SYMBOL	MILLIMETER		
	MIN	NOM	MAXO
A	80	0.85	0.900.
A1	00	0.02	0.05
A2	0.203REF.		
b	0.27	0.30	0.33
D	1.95	2.00	2.05
E	1.95	2.00	2.05
D1	0.92	0.95	0.98
E1	0.87	0.90	0.93
D2	0.53	0.56	0.59
E2	0.27	0.30	0.33
e	0.60	0.65	0.70
K1	0.25	0.28	0.31
K2	0.44	0.47	0.50
K3	0.34	0.37	0.40
L	0.22	0.25	0.28

9.Important Notice

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